

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOSII)

TPC8303

Lithium Ion Battery Applications Portable Equipment Applications Notebook PCs

• Low drain-source ON resistance : $RDS(ON) = 27 \text{ m}\Omega \text{ (typ.)}$

• High forward transfer admittance : $|Y_{fs}| = 7 \text{ S (typ.)}$

• Low leakage current $:I_{DSS} = -10 \mu A \text{ (max) (V}_{DS} = -30 \text{ V)}$

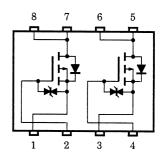
• Enhancement-mode : $V_{th} = -0.8 \sim -2.0 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA)}$

Maximum Ratings (Ta = 25°C)

Char	acteristics	Symbol	Rating	Unit	
Drain-source vol	tage	V _{DSS}	-30	V	
Drain-gate voltag	ge (R _{GS} = 20 kΩ)	V _{DGR}	-30	V	
Gate-source volt	age	V _{GSS}	±20	V	
. .	DC (Note 1)	ID	-4.5		
Drain current	Pulse (Note 1)	I _{DP}	-18	Α	
Drain power dissipation	Single-device operation (Note 3a)	P _{D (1)}	1.5	w	
(Note 3a) (Note 3a) (Note 2a) (Note 2a) Single-device value at dual operation (Note 3b) Orain power dissipation (Note 3a) PD(2) 1.0 PD(2) 1.0 O.75	VV				
Drain power dissipation	operation	P _{D (1)}	0.75	W	
(t = 10s) (Note 2b)	dissipation (Note 3a) (t = 10s) Single-device value	VV			
Single pulse ava	lanche energy (Note 4)	E _{AS}	26	mJ	
Avalanche curre	nt	I _{AR}	-4.5	Α	
Repetitive avalar Single-device va (Note		E _{AR}	0.10	mJ	
Channel tempera	ature	T _{ch}	150	°C	
Storage tempera	ture range	T _{stg}	-55~150	°C	

Weight: 0.08 g (typ.)

Circuit Configuration



Note: For (Note 1), (Note 2a), (Note 2b), (Note 3a), (Note 3b), (Note 4) and (Note 5), please refer to the next page.

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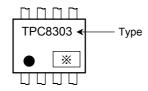
This transistor is an electrostatic sensitive device. Please handle with caution.

2002-04-18

Thermal Characteristics

Characteristics	Symbol	Max	Unit		
The amount of sixtenance of the amount of th	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	83.3	- °C/W	
Thermal resistance, channel to ambient (t = 10s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	125		
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a) (1)}	167	C/VV	
(t = 10s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	278		

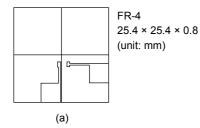
Marking (Note 6)

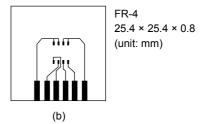


Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

- a) Device mounted on a glass-epoxy board (a)
- b) Device mounted on a glass-epoxy board (b)





Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.)
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.)

Note 4:
$$V_{DD}$$
 = -24 V, T_{ch} = 25°C (initial), L = 1.0 mH, R_G = 25 Ω , I_{AR} = -4.5 A

Note 5: Repetitive rating: pulse width limited by maximum channel temperature

Note 6: ● on lower left of the marking indicates Pin 1.

** shows lot number. (year of manufacture: last decimal digit of the year of manufacture, month of manufacture: January to December are denoted by letters A to L respectively.)

TPC8303



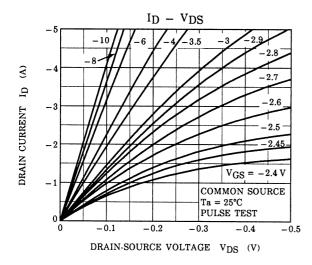
Electrical Characteristics (Ta = 25°C)

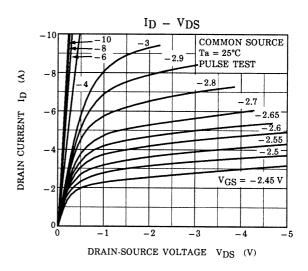
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$	-	_	-10	μΑ
Drain-source br	eakdown voltage	V _{(BR)DSS}	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-30	_	_	V
Dialii Source bi	eakdown voltage	V _{(BR) DSX}	$I_D = -10 \text{ mA}, V_{GS} = 20 \text{ V}$	-15	_	_	V
Gate threshold	/oltage	V_{th}	$V_{DS} = -10 \text{ V}, I_{D} = -1 \text{ mA}$	-0.8	_	-2.0	V
Drain-source O	N registance	R _{DS (ON)}	V _{GS} = -4 V, I _D = -2.2 A	— 55 65		65	mΩ
Dialii-Souice O	in resistance	R _{DS (ON)}	$V_{GS} = -10 \text{ V}, I_D = -2.2 \text{ A}$	10 -30150.82.0 - 55 65 - 27 35 3.5 7 970 180 370 17 20 75 160 -	35		
Forward transfe	r admittance	Y _{fs}	V _{DS} = -10 V, I _D = -2.2 A	3.5	7	_	S
Input capacitano	ce	C _{iss}		_	970	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	180	_	pF
Output capacitance		Coss		_	370	_	
	Rise time	t _r	V_{GS} $\stackrel{0}{\underset{-10}{\text{V}}}$ $\stackrel{I_{D}=-2.2 \text{ A}}{\underset{-10}{\overset{-1}{\underset{-10}{\text{VOLUB}}}}}$	_	17	_	
Switching time	Turn-ON time	t _{on}	$\begin{array}{c c} & & & & \\ & &$		20	_	ns
Switching time	Fall time	t _f	4 / / /	1	75		i iis
	Turn-OFF time	t _{off}	$V_{ m DD} \stackrel{.}{=} -15 m V$ Duty $\leq 1\%$, $t_{ m W} = 10 \mu m s$	_	160	_	
Total gate charge (Gate-source plus gate-drain)		Qg		_	28	_	
Gate-source charge		Q _{gs}	$V_{DD} \approx -24 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -4.5 \text{ A}$	_	16		nC
Gate-drain ("miller") charge		Q _{gd}		_	12	_	

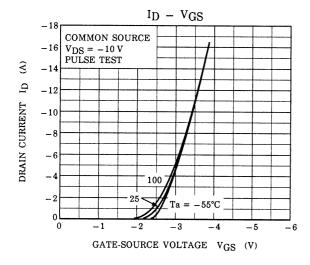
Source-Drain Ratings and Characteristics (Ta = 25°C)

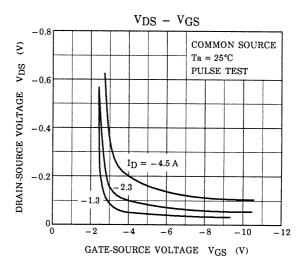
Charact	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	-18	Α
Forward voltage	(diode)	V _{DSF}	I _{DR} = -4.5 A, V _{GS} = 0 V	_	_	1.2	V

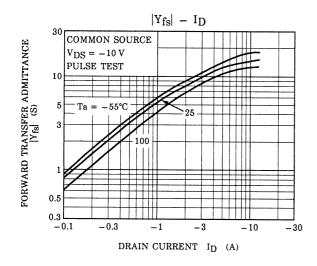
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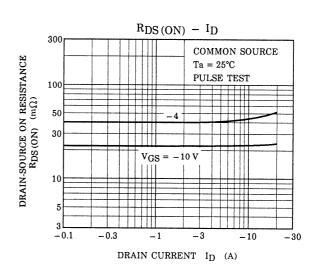




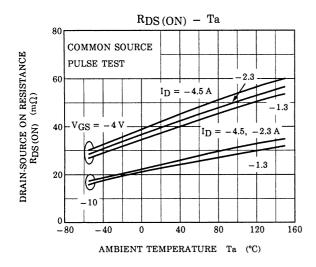


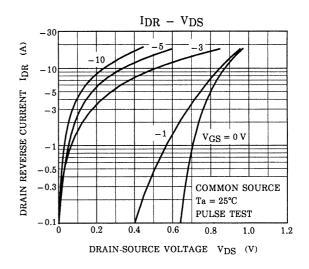


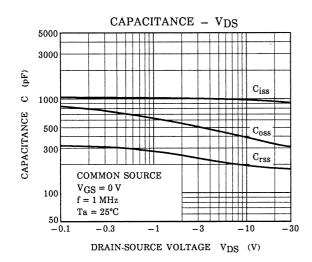


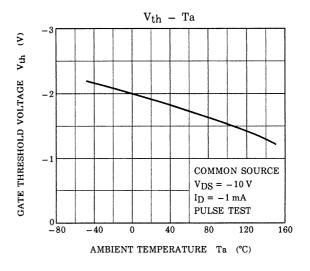


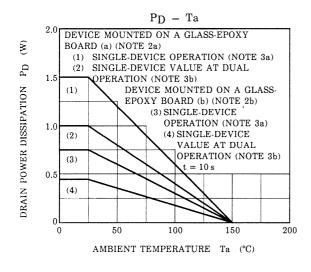
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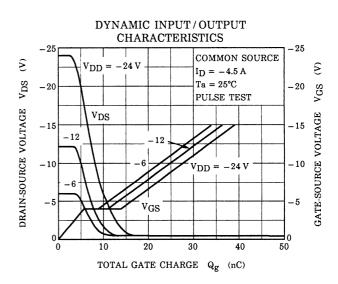




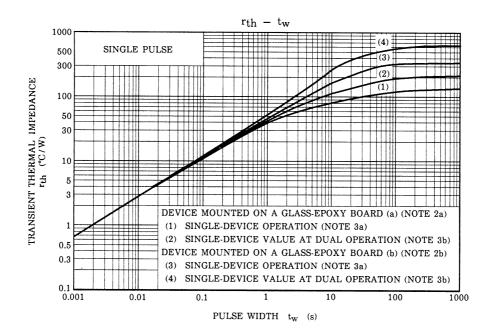




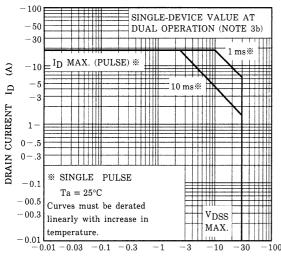




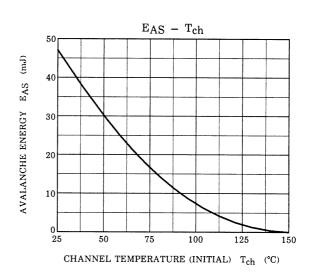
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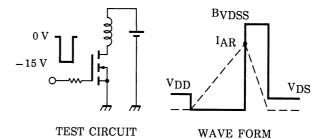






DRAIN-SOURCE VOLTAGE V_{DS} (V)





$$T_{ch}=25^{\circ}C$$
 (Initial)
 Peak $I_{AR}=-4.5\,A,~R_{G}=25\,\Omega~E_{AS}=\frac{1}{2}\cdot L\cdot I^{2}\cdot (~\frac{BVDSS}{BVDSS-V_{DD}})$
 $V_{DD}=-24\,V,~L=1.0\,mH$

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